

+15kV ESD Protected、2Mbps Data Rate RS-485

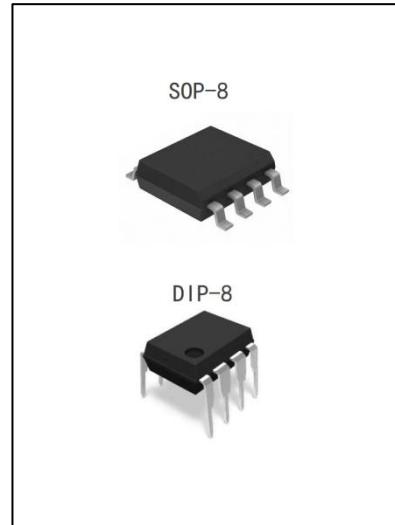
SSP485

General Description

The SSP485 is a half-duplex high speed transceiver for RS-485 and RS422 communication. IC contains one driver and one receiver.

The SSP485 has a fail-safe circuit. Each driver output and receiver input is protected against $\pm 15\text{kV}$ electrostatic discharge (HBM) (ESD)shocks.

The SSP485 receiver has 1/8 unit load input impedance, allows up to 256 devices can be attached to the bus. Mainly used in RS-485/RS-422 communication system.



Features

- I/O pin ESD protection: +15kV HBM
Other pins have level 3 ESD protection: >+8kV HBM
- Fractional unit load allows up to 256 devices on the bus
- + 5V operating voltage (For + 3.3v power supply, recommend the maximum transmission rate is 500Kbps)
- Data transmission up to 2Mbps
- Low current shutdown mode operating current: 1nA
- Current limiting and thermal turn-off function can be used for driver overload protection
- SOP8 and DIP8 package

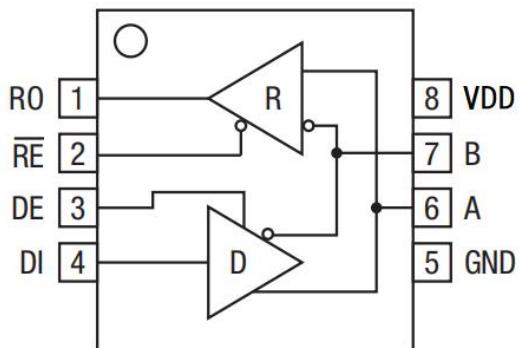
Applications

- Intelligent instrument
- Industrial process control
- Building automation network
- Motor control
- EMI sensitive transceiver application

Order specification

| Part No | Package | Manner of Packing | Devices per bag/reel |
|---------|---------|-------------------|----------------------|
| SSP485 | SOP8 | Reel | 2500 |

Block Diagram and Pin Arrangement Diagram



Pin Assignment

| Pin No. | Pin Name | Description | I/O |
|---------|----------|--|-----|
| 1 | RO | Receiver output: If $A-B \geq -0.05V$, RO will be high; If $A-B \leq -0.2V$, RO will be low; If A and B are open or shorted, RO will be high. | O |
| 2 | RE | Receiver output enable: RO is enabled when RE is low; RO is high impedance when RE is high. | I |
| 3 | DE | Driver output enable: The driver outputs, A and B are enabled by bringing DE high. They are high impedance when DE is low. | I |
| 4 | DI | Driver input: A low on DI forces output A low and output B high. Similarly, a high on DI forces output A high and output B low. | I |
| 5 | GND | Ground | |
| 6 | A | Receiver input and driver output | I/O |
| 7 | B | Receiver input and driver output | I/O |
| 8 | VDD | Supply voltage | |

Functional Description

The SSP485 is a half-duplex high speed transceiver for RS-485 and RS422 communication. IC contains one driver and one receiver. The SSP485 receiver has 1/8 unit load input impedance, allows up to 256 devices can be attached to the bus.

Receiver Truth Table

| Input | | | Output |
|-----------------|----|---------------|---------------|
| \overline{RE} | DE | A - B | RO |
| L | X | $\geq -0.05V$ | H |
| L | X | $\leq -0.2V$ | L |
| L | X | Open/shorted | H |
| H | H | X | Z |
| H | L | X | Z |

Driver Truth Table

| Input | | | Output | |
|-----------------|----|----|---------------|---|
| \overline{RE} | DE | DI | B | A |
| X | H | H | L | H |
| X | H | L | H | L |
| L | L | X | Z | Z |
| H | L | X | Z | |

Absolute Maximum Ratings

Unless specified otherwise, Tamb= 25°C

| Parameter | Symbol | Value | Unit |
|----------------------------|---------------------------------------|------------------------------|------|
| Supply Voltage | V _{DD} | -0.3~7 | V |
| Input / Output Voltage | V _{IN/V_{OUT}} | GND-0.3~V _{DD} +0.3 | V |
| A/B Input / Output Voltage | V _{INA/B/V_{OUTA/B}} | -13~13 | V |
| Operating Temperature | T _{amb} | -40~85 | °C |
| Storage Temperature | T | -65~150 | °C |

DC Electrical Characteristics

Unless specified otherwise, VDD=5V±5%, Tamb= 25°C

| Parameter | Symbol | Test Conditions | Min | Typ | Max | Unit |
|---|-------------------|--|------|------|-----|------|
| Driver | | | | | | |
| Differential driver output | V _{OD1} | No load | | | 5 | V |
| Differential driver output | V _{OD2} | R=50Ω (RS-422) ⁽¹⁾ | 2.0 | | | V |
| | | R=27Ω (RS-485) ⁽¹⁾ | 1.5 | | | V |
| Change in magnitude of driver differential output voltage for complementary output states | Δ V _{OD} | R=50Ω or 27Ω ⁽¹⁾ | | 0.01 | 0.2 | V |
| Driver common-mode output voltage | V _{OC} | R=50Ω or 27Ω ⁽¹⁾ | | | 3 | V |
| Change in magnitude of driver common-mode output voltage for complementary output states | Δ V _{OC} | R=50Ω or 27Ω ⁽¹⁾ | | 0.01 | 0.2 | V |
| Input high voltage | V _{IH1} | DE、 \overline{RE} 、DI | 2.0 | | | V |
| Input low voltage | V _{IL1} | DE、 \overline{RE} 、DI | | | 0.8 | V |
| Input current | I _{IN1} | DE、 \overline{RE} 、DI | -2 | | 2 | μA |
| Input current (A, B) | I _{IN2} | DE=GND, Vin=12V | | | 125 | μA |
| | | V _{DD} =GND or 5.25V Vin=-7V | | | -75 | μA |
| Driver short-circuit current | I _{OD1} | -7V≤V _{OUT} ≤V _{DD} | -250 | | | mA |
| | | 0V≤V _{OUT} ≤12V | | | 250 | mA |
| | | 0V≤V _{OUT} ≤V _{DD} | ±25 | | | mA |
| Receiver | | | | | | |
| Differential threshold voltage | V _{TH} | -7V≤V _{CM} ≤12V | -200 | -125 | -50 | mV |
| input hysteresis voltage | Δ V _{TH} | | | 25 | | mV |
| output high voltage | V _{OH} | I _O =-4mA, V _{ID} =-50mV | 3.5 | | | V |
| output low voltage | V _{OL} | I _O =4mA, V _{ID} =-200mV | | | 0.4 | V |
| 3-state(high impedance) output current at receiver | I _{OZR} | 0.4V≤V _O ≤2.4V | | | ±1 | μA |
| input resistance | R _{IN} | -7V≤V _{CM} ≤12V | 96 | | | kΩ |
| Receiver short-circuit current | I _{OSR} | 0V≤V _{RO} ≤V _{DD} | ±7 | | ±95 | mA |

| | | | | | | | |
|----------------------------|------------|---|-------------|--|----------|-----|---------|
| Supply Current | I_{CC} | No load, $\overline{RE}=DI$ =GND or V_{DD} | $DE=V_{DD}$ | | 450 | 900 | μA |
| | | | $DE=GND$ | | 450 | 600 | μA |
| Supply Current in Shutdown | I_{SHDN} | DE=GND, $\overline{RE}=V_{DD}$ | | | | 10 | μA |
| ESD Protection (A/B) | ESD | Human Body Model | | | ± 15 | | kV |

Transmission characteristics

Unless specified otherwise, $VDD=5V\pm 5\%$, $Tamb= 25^\circ C$

| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit |
|--------------------------------|------------------|--|------|------|----------|------|
| Driver Input to Output | t_{DPLH} | $R_{DIFF}=54\Omega$, $C_{L1}=C_{L2}=100pF^{(2)}$ | | 34 | 60 | ns |
| Driver Input to Output | t_{DPHL} | $R_{DIFF}=54\Omega$, $C_{L1}=C_{L2}=100pF^{(2)}$ | | 34 | 60 | ns |
| $ t_{DPLH}-t_{DPHL} $ | t_{DSKEW} | $R_{DIFF}=54\Omega$, $CL1=CL2=100pF^{(2)}$ | | -2.5 | ± 10 | ns |
| Driver Rise or Fall Time | t_{DR}, t_{DF} | $R_{DIFF}=54\Omega$, $C_{L1}=C_{L2}=100pF^{(2)}$ | | 14 | 25 | ns |
| Maximum Data Rate | f_{MAX} | | | 2 | | Mbps |
| Driver Enable to Output High | t_{DZH} | $C_L=100pF$, S2 closed ⁽³⁾ | | | 150 | ns |
| Driver Enable to Output Low | t_{DZL} | $C_L=100pF$, S1 closed ⁽³⁾ | | | 150 | ns |
| Driver Disable Time from Low | t_{DLZ} | $C_L=15pF$, S1 closed ⁽³⁾ | | | 100 | ns |
| Driver Disable Time from Low | t_{DHZ} | $C_L=15pF$, S2 closed ⁽³⁾ | | | 100 | ns |
| Receiver Input to Output | t_{RPLH} | $ V_{ID} \geq 2.0V$ Rise or Fall Time $\leq 15ns^{(4)}$ | | 106 | 150 | ns |
| Receiver Input to Output | t_{RPBL} | | | 106 | 150 | ns |
| $ t_{RPLH}-t_{RPBL} $ | t_{RSKD} | $ V_{ID} \geq 2.0V$ Rise or Fall Time $\leq 15ns^{(4)}$ | | 0 | ± 10 | ns |
| Receiver Enable to Output Low | t_{RZL} | $C_L=100pF$, S1 closed ⁽⁵⁾ | | 20 | 50 | ns |
| Receiver Enable to Output High | t_{RZH} | $C_L=100pF$, S2 closed ⁽⁵⁾ | | 20 | 50 | ns |

| | | | | | | |
|--|-----------------|---|----|-----|------|----|
| Receiver Disable Time from Low | t_{RLZ} | $C_L=100\text{pF}$, S1 closed ⁽⁵⁾ | | 20 | 50 | ns |
| Receiver Disable Time from High | t_{RHZ} | $C_L=100\text{pF}$, S2 closed ⁽⁵⁾ | | 20 | 50 | ns |
| Time to Shutdown | t_{SHDN} | | 50 | 200 | 600 | ns |
| Driver Enable from Shutdown to Output High | $t_{DZH(SHDN)}$ | $C_L=15\text{pF}$, S2 closed ⁽³⁾ | | | 250 | ns |
| Driver Enable from Shutdown to Output Low | $t_{DZL(SHDN)}$ | $C_L=15\text{pF}$, S1 closed ⁽³⁾ | | | 250 | ns |
| Receiver Enable from Shutdown to Output High | $t_{RZH(SHDN)}$ | $C_L=100\text{pF}$, S2 closed ⁽³⁾ | | | 3500 | ns |
| Receiver Enable from Shutdown to Output Low | $t_{RZL(SHDN)}$ | $C_L=100\text{pF}$, S1 closed ⁽³⁾ | | | 3500 | ns |

Note:

- (1) Test circuit is shown in Figure 1
- (2) Test circuit is shown in Figure 2
- (3) Test circuit is shown in Figure 3
- (4) Test circuit is shown in Figure 4
- (5) Test circuit is shown in Figure 5

Test Circuit

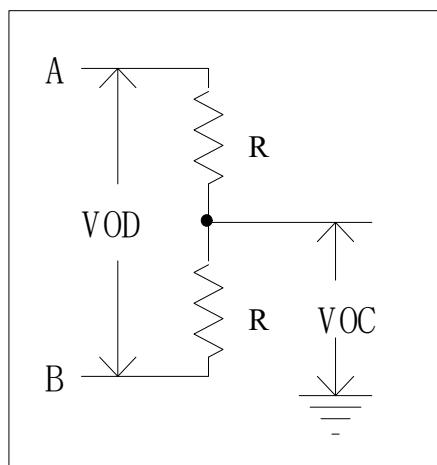


Figure 1 Driver DC Test Circuit

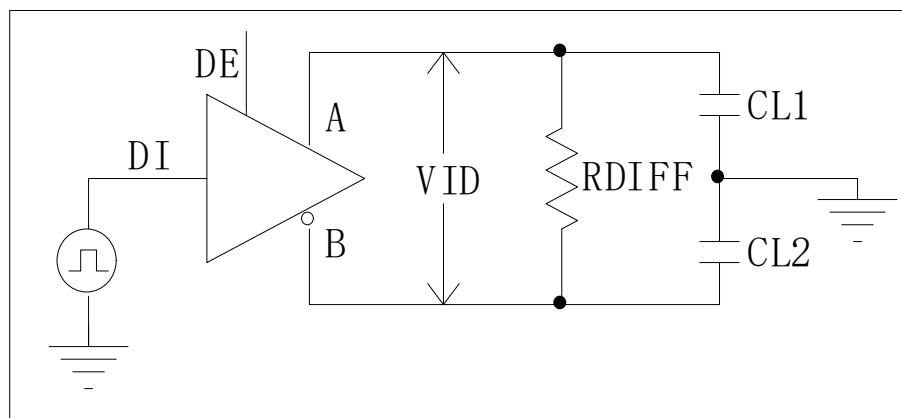


Figure 2 Driver Timing Test Circuit

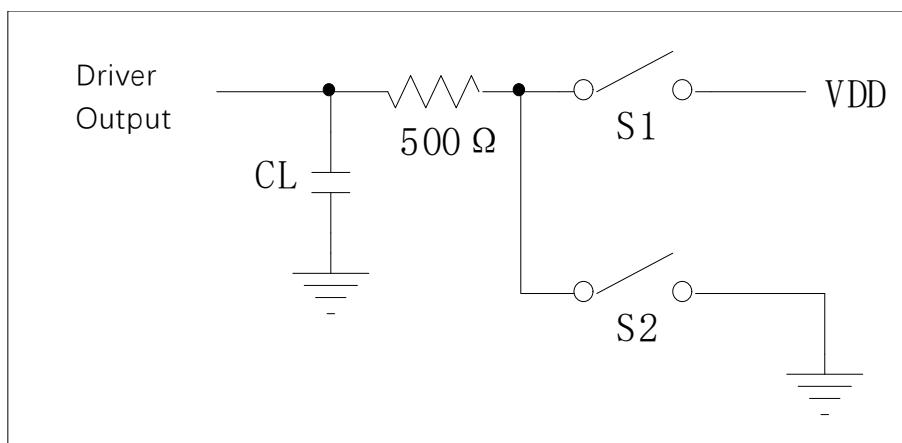


Figure 3 Driver Enable/Invalid Timing Test Circuit

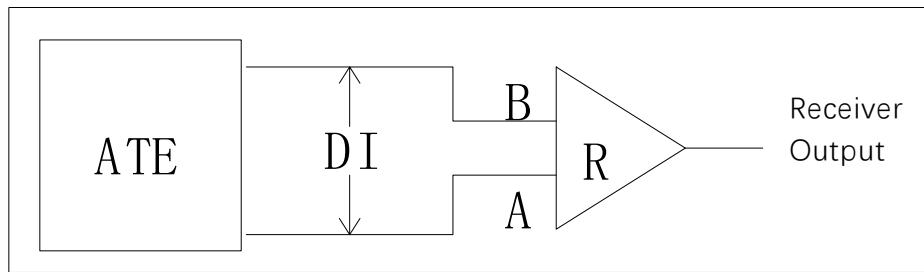


Figure 4 Receiver Propagation Delay Test Circuit

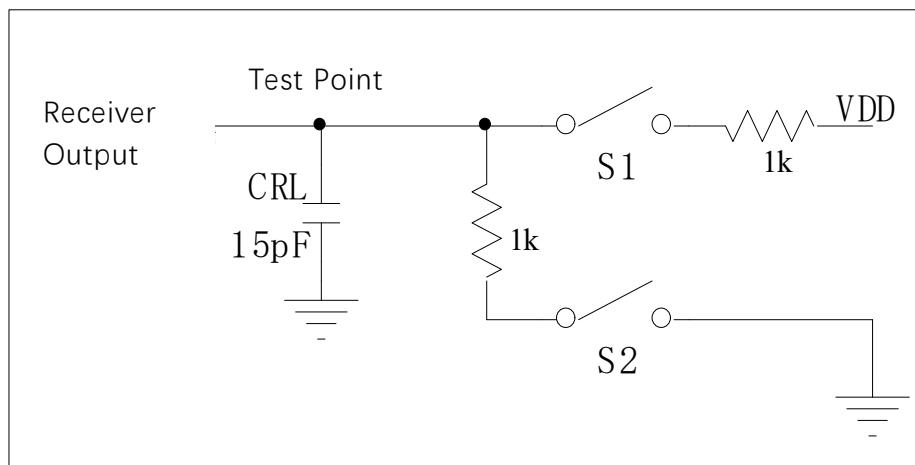


Figure 5 Receiver Enable/Invalid Timing Test Circuit

Application Circuits

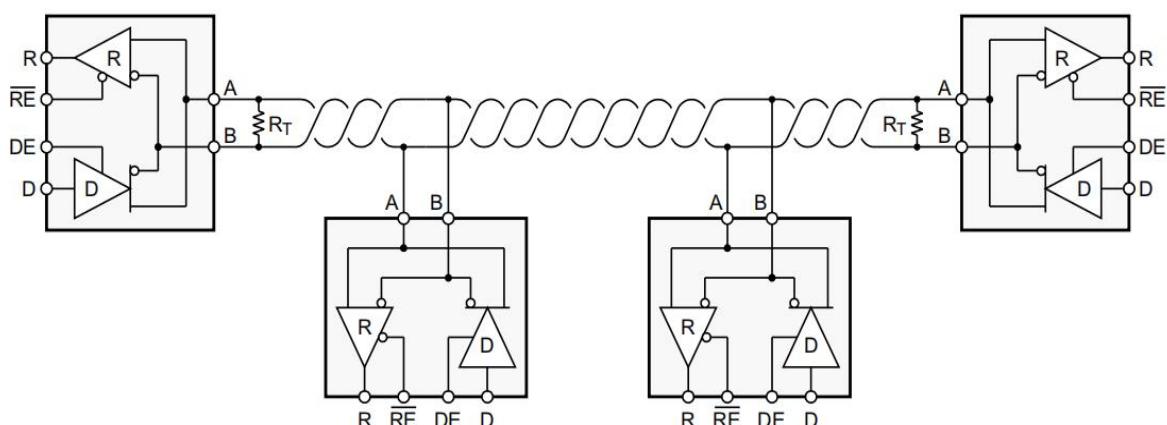
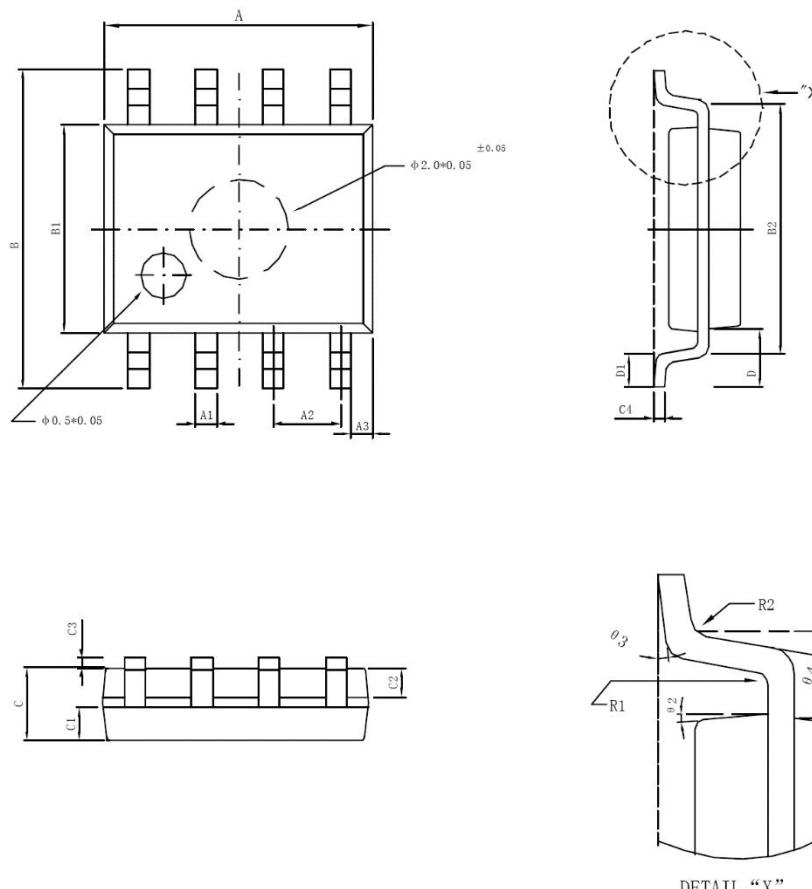


Figure 6 Typical Application Chart

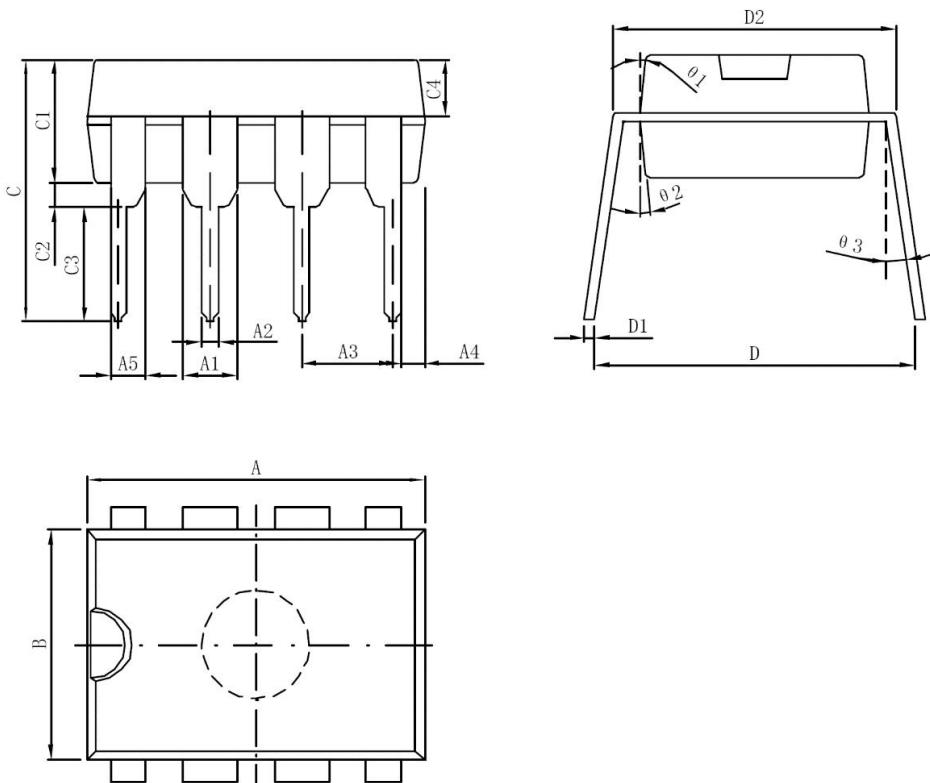
Transceivers are designed for bidirectional data communication over multi-point bus transmission lines. Figure 6 shows a typical network application circuit. These devices can also be used as linear transponders with cable lengths up to 4000 ft. In order to reduce reflection, terminals should be matched with their characteristic impedance at both ends of the transmission line, and the length of the branch line outside the main line should be as short as possible.

Package Information (SOP8)



| Symbol | Min. (mm) | Max.(mm) | Symbol | Min.(mm) | Max.(mm) |
|-----------|-----------|----------|-----------|----------|----------|
| A | 4.95 | 5.15 | C3 | 0.10 | 0.20 |
| A1 | 0.37 | 0.47 | C4 | | 0.20TYP |
| A2 | | 1.27TYP | D | | 1.05TYP |
| A3 | | 0.41TYP | D1 | | 0.50TYP |
| B | 5.80 | 6.20 | R1 | | 0.07TYP |
| B1 | 3.80 | 4.00 | R2 | | 0.07TYP |
| B2 | | 5.0TYP | θ1 | | 17°TYP |
| C | 1.30 | 1.50 | θ2 | | 13°TYP |
| C1 | 0.55 | 0.65 | θ3 | | 4°TYP |
| C2 | 0.55 | 0.65 | θ4 | | 12°TYP |

Package Information (DIP8)



| Symbol | Min. (mm) | Max. (mm) | Symbol | Min. (mm) | Max. (mm) |
|--------|-----------|-----------|--------|-----------|-----------|
| A | 9.30 | 9.50 | C2 | | 0.50 |
| A1 | | 1.524 | C3 | | 3.3 |
| A2 | 0.39 | 0.53 | C4 | | 1.57TYP |
| A3 | | 2.54 | D | 8.20 | 8.80 |
| A4 | | 0.66TYP | D1 | 0.20 | 0.35 |
| A5 | | 0.99TYP | D2 | 7.62 | 7.87 |
| B | 6.3 | 6.5 | θ1 | | 8°TYP |
| C | | 7.20 | θ2 | | 8°TYP |
| C1 | 3.30 | 3.50 | θ3 | | 5°TYP |

Special Instructions

The company reserves the right of final interpretation of this specification.

Version Change Description

Version: V1.6

Author: Yangyang

Time: 2021.8.12

Modify the record:

1. Re-typesetting the manual and checking some data
-

Version: V1.7

Author: Yangyang

Time: 2022.10.13

Modify the record:

1. Deleting the description and parameters of slew-rate-limited
-

Statement

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